Qualification Results Summary of AD623 Die Revision in SOIC_N Package

QUALIFICATION RESULTS				
TEST	SPECIFICATION	SAMPLE SIZE	RESULTS	
High Temperature Operating Life (HTOL)	JEDEC JESD22-A108	9x77	Pass	
Highly Accelerated Stress Test (HAST)*	JEDEC JESD22-A110	9x77	Pass	
Temperature Cycle (TC)*	JEDEC JESD22-A104	9x77	Pass	
High Temperature Storage Life (HTSL)	JEDEC JESD22-A103	3x77	Pass	
Solder Heat Resistance (SHR)*	JEDEC/IPC J-STD-020	3x11	Pass	
Latch-Up	JEDEC JESD78		Pass	
Electrostatic Discharge Human Body Model	ESDA/JEDEC JS-001	3/voltage	Pass 4000V	
Electrostatic Discharge Field-Induced Charged Device Model	JEDEC JESD22-C101	3/voltage	Pass 1250V	

^{*}These samples were subjected to preconditioning (per J-STD-020 Level 1) prior to the start of the stress test. Level 1 preconditioning consists of the following: 1. Bake – 24 hours at 125°C; 2. Soak – unbiased soak for 168 hours at 85C, 85%RH; 3. Reflow – three passes through a reflow oven with a peak temperature of 260°C.

Qualification Results Summary of AD623 Die Revision in MSOP Package

QUALIFICATION RESULTS				
TEST	SPECIFICATION	SAMPLE SIZE	RESULTS	
High Temperature Operating Life (HTOL)	JEDEC JESD22-A108	9x77	Pass	
Highly Accelerated Stress Test (HAST)*	JEDEC JESD22-A110	9x77	Pass	
Temperature Cycle (TC)*	JEDEC JESD22-A104	9x77	Pass	
High Temperature Storage Life (HTSL)	JEDEC JESD22-A103	3x77	Pass	
Solder Heat Resistance (SHR)*	JEDEC/IPC J-STD-020	3x11	Pass	
Latch-Up	JEDEC JESD78		Pass	
Electrostatic Discharge Human Body Model	ESDA/JEDEC JS-001	3/voltage	Pass 4000V	
Electrostatic Discharge Field-Induced Charged Device Model	JEDEC JESD22-C101	3/voltage	Pass 1250V	

^{*}These samples were subjected to preconditioning (per J-STD-020 Level 1) prior to the start of the stress test. Level 1 preconditioning consists of the following: 1. Bake – 24 hours at 125°C; 2. Soak – unbiased soak for 168 hours at 85C, 85%RH; 3. Reflow – three passes through a reflow oven with a peak temperature of 260°C.